

2SB0929 (2SB929), 2SB0929A (2SB929A)

Silicon PNP epitaxial planar type

For power amplification

Complementary to 2SD1252, 2SD1252A

■ Features

- High forward current transfer ratio h_{FE} which has satisfactory linearity
- Low collector-emitter saturation voltage $V_{CE(sat)}$
- N type package enabling direct soldering of the radiating fin to the printed circuit board, etc. of small electronic equipment.

■ Absolute Maximum Ratings $T_C = 25^\circ C$

Parameter		Symbol	Rating	Unit
Collector-base voltage (Emitter open)	2SB0929	V_{CBO}	-60	V
	2SB0929A		-80	
Collector-emitter voltage (Base open)	2SB0929	V_{CEO}	-60	V
	2SB0929A		-80	
Emitter-base voltage (Collector open)		V_{EBO}	-5	V
Collector current		I_C	-3	A
Peak collector current		I_{CP}	-5	A
Collector power dissipation		P_C	35	W
			1.3	
$T_a = 25^{\circ}\text{C}$				
Junction temperature		T_J	150	$^{\circ}\text{C}$
Storage temperature		T_{stg}	-55 to +150	$^{\circ}\text{C}$

■ Electrical Characteristics $T_C = 25^\circ C \pm 3^\circ C$

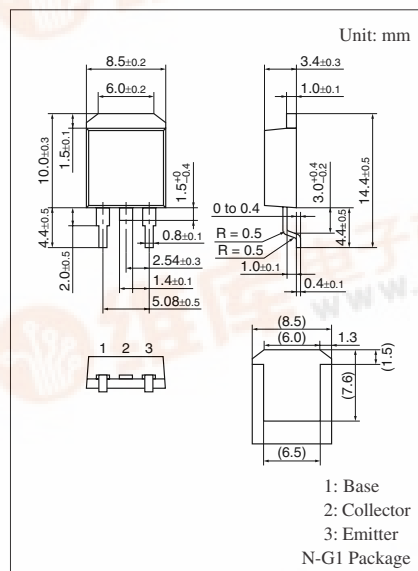
Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-emitter voltage (Base open)	V_{CEO}	$I_C = -30 \text{ mA}, I_B = 0$	-60			V
			-80			
Collector-emitter cutoff current (E-B short)	I_{CES}	$V_{CE} = -60 \text{ V}, V_{BE} = 0$			-200	μA
		$V_{CE} = -80 \text{ V}, V_{BE} = 0$			-200	
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = -30 \text{ V}, I_B = 0$			-300	μA
		$V_{CE} = -60 \text{ V}, I_B = 0$			-300	
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = -5 \text{ V}, I_C = 0$			-1	mA
Forward current transfer ratio	h_{FE1}^*	$V_{CE} = -4 \text{ V}, I_C = -1 \text{ A}$	70		250	—
	h_{FE2}	$V_{CE} = -4 \text{ V}, I_C = -3 \text{ A}$	10			
Base-emitter voltage	V_{BE}	$V_{CE} = -4 \text{ V}, I_C = -3 \text{ A}$			-1.8	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -3 \text{ A}, I_B = -0.375 \text{ A}$			-1.2	V
Transition frequency	f_T	$V_{CE} = -10 \text{ V}, I_C = -0.5 \text{ A}, f = 10 \text{ MHz}$		30		MHz
Turn-on time	t_{on}	$I_C = -1 \text{ A}$		0.5		μs
Strage time	t_{stg}	$I_{B1} = -0.1 \text{ A}, I_{B2} = 0.1 \text{ A}$		1.2		μs
Fall time	t_f	$V_{CC} = -50 \text{ V}$		0.3		μs

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

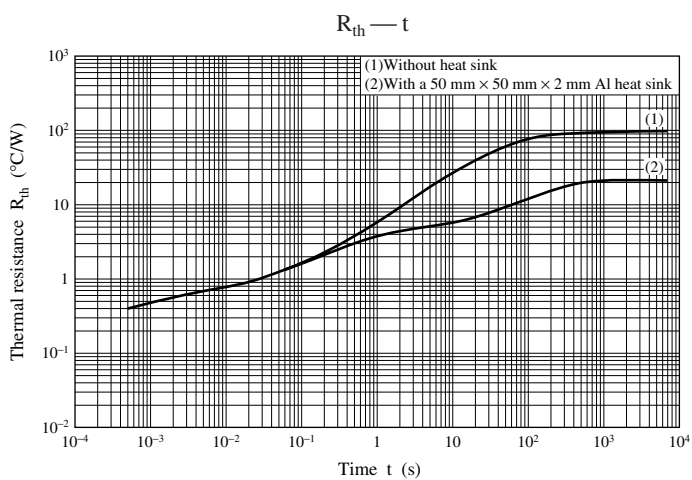
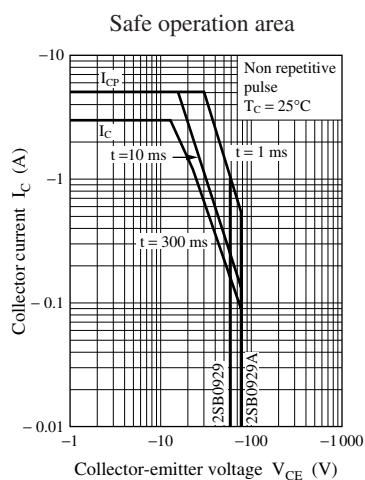
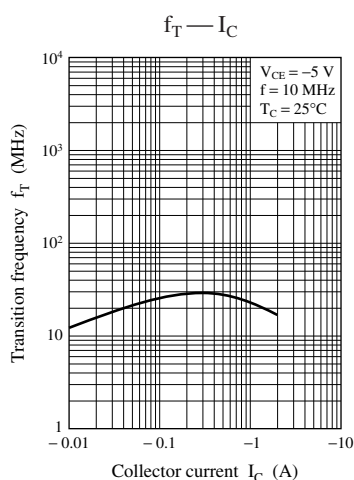
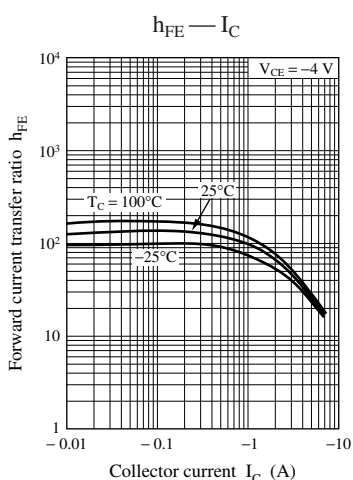
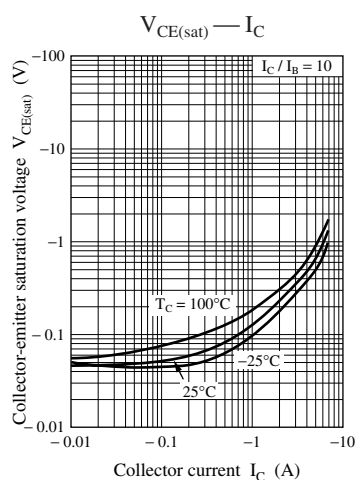
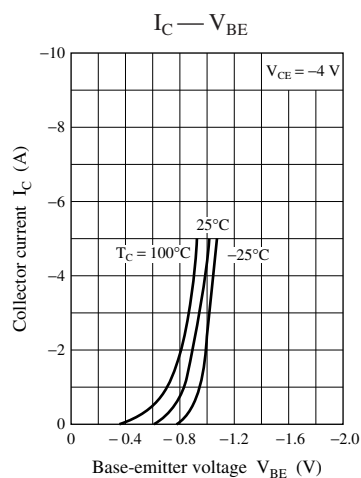
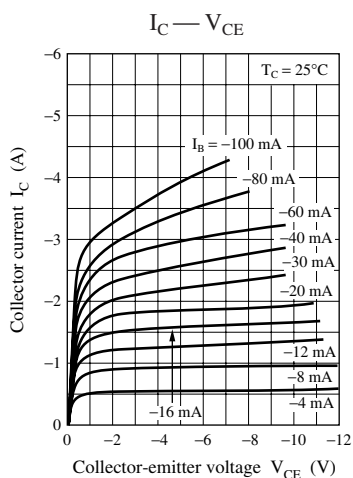
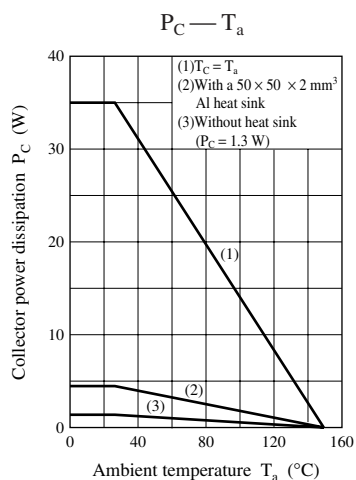
2. Rank classification

Rank	Q	P
h_{FE1}	70 to 150	120 to 250

Note) The part number in the parenthesis shows conventional part number.



Note) Self-supported type package is also prepared.



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